

<b>Notice of References Cited</b>	Application/Control No. 10/552,532	Applicant(s)/Patent Under Reexamination HAYASHI, YASUSHI	
	Examiner AMENE S. BAYOU	Art Unit 3746	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0126250	07-2004	Tsuchiya et al.	417/368
	B	US-			
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**FOREIGN PATENT DOCUMENTS**

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